Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/781,895	ISHIHARA ET AL.	
Examiner	Art Unit	
John Q. Nguyen	3654	

		•			
SEARCHED					
Class	Subclass	Date	Examiner		
242	338.1 343 348 348.2	9/16/2005	JN		
360	132	9/16/2005	JN		
		-			
•		-			
	,				
			-		

INT	INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner			
		· · · · · · · · · · · · · · · · · · ·				

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
•				
		.		
	,			
	:			
	,			
•				
i				
·				